

<b>Notice of References Cited</b>		Application/Control No. 10/623,603	Applicant(s)/Patent Under Reexamination GUAN ET AL.	
		Examiner Scott A. Rogers	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,647,010 A	07-1997	Okubo et al.	382/100
*	B US-2005/0190411 A1	09-2005	Ohno, Hajime	358/3,28
*	C US-2007/0041608 A1	02-2007	Maeno, Kurato	382/100
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 02029679 A	01-1990	Japan	MAEKAWA, HIROICHI	B41M 3/14
O	JP 2001346032 A	12-2001	Japan	MATSUNOSHITA et al.	H04N 1/387
P	JP 2001069340 A	03-2001	Japan	SAKAGAMI, TSUTOMU	H04N 1/387
Q	JP 2002305646 A	10-2002	Japan	MATSUNOSHITA et al.	H04N 1/382
R	JP 2002112356 A	04-2002	Japan	YAMAKADO et al.	H04N 1/387
S	JP 2002112357 A	04-2002	Japan	YAMAGUCHI et al.	H04N 1/387
T	JP 09164739 A	06-1997	Japan	KONNAI, KATSUMI	G06F 3/12

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U		
V		
W		
X		

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